Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	2343	324/658,686,537.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/10 21:59
L2	30	(capacitively near3 coupl\$4) with test\$4 with (integrated adj circuit or IC)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/10 22:04
L3	3	L2 and 1	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/10 21:59
L4	22	("4779041"   "4789829"   "4918376"   "5124660"   "5254953"   "5266901"   "5557209").PN. OR ("5696451").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/06/10 22:03
L5	2256	714/25,736,737,819.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2006/06/10 22:04
L6	1	2 and 5	US-PGPUB; USPAT; USOCR	OR	ON	2006/06/10 22:04
L7	7	(capacitively near3 probe) with test\$4 with (integrated adj circuit or IC)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/10 22:05
L8	1	1 and 7	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/10 22:04
L14	9	("4488301"   "4709366"   "5254953"   "5274336"   "5381417"   "5498964"   "5557209"   "5696451"   "5786697").PN. OR ("6998849"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/06/10 22:05
L15	396	(capacitive adj coupling) with (test adj plate or probe)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/10 22:07

L16	23	1 and 15	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/10 22:08
L17	0	5 and 15	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/10 22:08
L18	191	conductive adj plate near5 integrat\$4	US-PGPUB; USPAT; USOCR	OR	ON	2006/06/10 22:08
L19	4	L18 and 324/760-765,158.1.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2006/06/10 22:08
L20	1	L19 and 15	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/06/10 22:08
S1	21751	(test\$4 and capacit\$6).ti,ab.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:13
S2	8766	324/765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/03 15:28
S3	252	S1 and S2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/03 15:31
S4	37	S3 and transmit\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/03 15:41
S5	25	(capacitively near3 coupl\$4) with test\$4 with (integrated adj circuit or IC)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/03 15:42

6/10/06 10:08:56 PM C:\Documents and Settings\TNguyen52\My Documents\EAST\Workspaces\10691020.wsp

S6	4	S2 and S5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/03 15:42
S7	10	("4743841"   "5124660"   "5130645"   "5254953"   "5391993"   "5420500"   "5434502"   "5517110"   "5570034"   "5631572").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/06/03 15:45
S8	15750	(integrated adj circuit or IC) near4 die	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/07 14:00
S9	25	(capacitively near3 coupl\$4) with test\$4 with (integrated adj circuit or IC)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/07 14:00
S10	7	S9 and S8	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/07 14:32
S11	32710	integrated adj circuit near3 memory	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/07 14:33
S12	1	S11 and S9	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/07 14:35
S13	685	oscillator with buffer adj circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/07 14:36
S14	0	S9 and S13	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/07 14:36
S15	8773	324/765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/07 14:36

	Т					
S16	1	S13 and S15	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/07 15:18
S17	0	("6,285,201B1").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/06/07 15:18
S18	2	("6,285,201").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/06/07 15:21
S19	11	(("3,782,504") or ("4,280,221") or ("5,974,464") or ("6,690,309") or ("6,859,883")).PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/06/07 15:23
S20	9	(("5,786,979") or ("5,818,112") or ("6,496,889") or ("6,500,696")).PN. or (2001/0039075).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/06/07 15:23
S21	20	test adj plate near4 integrat\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:18
S22	43	test adj plate with integrat\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:18
S23	5	("4621233"   "5037771"   "5543334"   "5699282").PN. OR ("5942911"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/22 10:43
S24	176	conductive adj plate near5 integrat\$4	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/22 10:44
S25	3	S24 and 324/760-765,158.1.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/22 10:44

S26	46	("3798541"   "3975680"   "4056773"   "4114093"   "4186338"   "4520318"   "4565966"   "4583042"   "4620304"   "4695788"   "4779041"   "4789829"   "4801866"   "4801878"   "4994605"   "4896108"   "4918376"   "4928057"   "5006808"   "5081421"   "5101152"   "5111137"   "5124660"   "5132607"   "5138266"   "5187430"   "5231357"   "5254953"   "5308250").PN. OR ("5420500").	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/22 10:58
		"5308250").PN. OR ("5420500"). URPN.				

6/10/06 10:08:56 PM C:\Documents and Settings\TNguyen52\My Documents\EAST\Workspaces\10691020.wsp Page 5